Search Notes

Application No.	Applicant(s)
10/003,051	WEESE ET AL.
Examiner Duy M. DANG	Art Unit
Bami Chaphia	2627

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Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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IEEE, NPL	4/20/2005	СН		
INVENTOR NAME SEARCH	4/20/2005	СН		
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